

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Shunpei Yamazaki, et al. Art Unit : 2813
Serial No. : 09/451,665 Examiner : Laura Schillinger
Filed : November 30, 1999
Title : SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicant submits that an Information Disclosure Statement (IDS) was filed on May 6, 2004. Upon review of the previously filed IDS, we noted that two of the references (Design ID "AM" and "AN") were not listed as having Abstracts attached. Applicant respectfully request that the attached corrected form PTO-1449 be initialed and returned.

No fee is believed to be due in connection with this paper. Please apply any charges or credits to Deposit Account No. 06-1050.

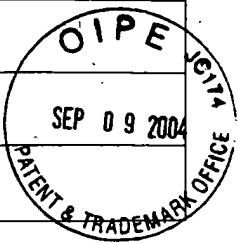
Respectfully submitted,

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Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 07977-017002	Application No. 09/451,665
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Shunpei Yamazaki, et al.			
		Filing Date November 30, 1999	Group Art Unit 2813		



U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	3,891,468	06/24/1975	Ito et al.			
	AB	4,472,871	09/25/1984	Green et al.			
	AC	5,396,084	03/07/1995	Matsumoto			
	AD	5,594,371	01/14/1997	Douseki			
	AE	5,914,498	06/22/1999	Suzawa et al.			
	AF						
	AG						
	AH						
	AI						
	AJ						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Sub-class	Translation
							Yes No
	AK	JP 04-302147	26 OCT 1992	JAPAN			Abstract
	AL	JP 05-082552	02 APR 1993	JAPAN			Abstract
	AM	03-189626	08/19/1991	JAPAN			Abstract
	AN	04-290467	10/15/1992	JAPAN			Abstract
	AO	06-029834	02/04/1994	JAPAN			Abstract
	AP	08-228145	09/03/1996	JAPAN			Abstract
	AQ	64-7559	01/11/1989	JAPAN			Abstract
	AR	EP 0 690 510	01/03/1996	EUROPE			In English

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AS	
	AT	
	AU	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	